



## **EMC COMPLIANCE TEST REPORT**

For

**LED Sports Light** 

Trade Name : V-TAC

**Model Number**: VT-500D VT-501D

**Serial Number** : N/A

**Report Number** : TK190108209-S-E

**Date** : January 08 2019

**Regulations** : See below

Standards	Results (Pass/Fail)
EN 55015: 2013;/A1: 2015	PASS
EN 61000-3-2: 2014	PASS
EN 61000-3-3: 2013;	PASS
EN 61547: 2009;	PASS
,	

#### Prepared for:

### V-TAC Exports Limited

Room No 301, Kam On Building, 176A Queens Road Central, Central, Hong Kong.

#### Prepared by:

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## **EC-Declaration of Conformity**

For the following equipment:	
( Product Name )	
LED SPORTS LIGHT ( Model Designation / Trade name )	<del></del>
VT-500D VT-501D	<b>▼-T</b> ▲C°
( Manufacturer Name ) V-TAC Exports Limited	
(Manufacturer Address)	
Room No 301, Kam On Building, 17	76A Queens Road Central, Central, Hong Kong.
is herewith confirmed to comply with	h the requirements set out in the Council Directive on the
	lember States relating to Electromagnetic Compatibility Directive
• •	rding the Electromagnetic Compatibility the following standards are
applied: $V$ EN 55015: 2013; $V$ EN 61000-3-2: 2014 $V$ EN 61000-3-3: 2013; $V$ EN 61547: 2009;	
<b>V</b> EN 61000-3-2: 2014	
V EN 61000-3-3: 2013;	
<b>V</b> EN 61547: 2009;	
The following manufacturer / import	er or authorized representative established within the EUT is
responsible for this declaration:	er of authorized representative established within the EOT is
V-TAC Exports Limited	
( Company Name )	
` '	76A Queens Road Central, Central, Hong Kong.
( Company Address )	
Person responsible for making this de	eclaration:
reson responsible for making this e	
( Name, Surname )	
(Traine, Barnaine)	
( Position / Title )	P
,	my
( Place )	(Date) (Legal Signature)
	OVE TECHNOLOGY CO
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	TEST REPORT





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## **VERIFICATION OF COMPLIANCE**

**Equipment Under Test:** LED Sports Light

Trade Name:

**Model Number:** VT-500D VT-501D

Serial Number: N/A

**Applicant:** V-TAC Exports Limited

Room No 301, Kam On Building, 176A Queens Road Central, Central, Hong

Kong.

**Manufacturer:** V-TAC Exports Limited

Room No 301, Kam On Building, 176A Queens Road Central, Central, Hong

Kong.

**Type of Test:** EMC Directive 2014/30/EU for CE Marking

**Technical Standards:** EN 61000-3-3: 2013

EN 55015: 2013/A1: 2015

EN 61547: 2009; EN61000-3-2:2014

**File Number:** TK190108209-S-E

**Date of test:** January 08 2019

**Deviation:** None

**Condition of Test** Normal

Sample:

The above equipment was tested by TOKE Laboratory Co.,Ltd. for compliance with the requirements set forth in EMC Directive 2014/30/EU and the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Approved by Authorized Signatory:

SALON OUYANG (Q.A. Manager



## **GENERAL INFORMATION**

**Applicant:** V-TAC Exports Limited

Room No 301, Kam On Building, 176A Queens Road Central, Central, Hong

Kong

Manufacturer: V-TAC Exports Limited

Room No 301, Kam On Building, 176A Queens Road Central, Central, Hong

Kong

**File Number:** TK190108209-S-E

**Date of Test:** January 08 2019

**Equipment Under** 

**Test:** 

LED SPORTS LIGHT

**Model Number:** VT-500D VT-501D

**Serial Number:** N/A

**Type of Test:** EMC Directive 2014/30/EU arking

**Technical Standards:** EN 55015: 2013/1 : 2015

EN 61000-3-2: 2014; EN 61000-3-3: 2013; EN 61547: 2009;

**Frequency Range** 9kHz to 30MHz for Line Conducted Test

**(EN 55015):** 30MHz to 1000MHz for Radiated Emission Test

Test Site TOKE LABORATORY CO., LTD.

No. 7, Xinshidai industrial, Guantian Village, Shiyan Town, Baoan District,

Shenzhen, China



## **SYSTEM DESCRIPTION**

## **EUT Test Program:**

- 1. Set up EUT with the auxiliary equipment.
- 2. Let EUT work in the test mode and measure it.





## **PRODUCT INFORMATION**

**EUT Sheathing Material**: LED SPORTS LIGHT

**EUT Power Rating:** AC100-240V, 50/60Hz,

**Power during Test:** AC 240V / 50Hz

**DC Power Cable:** N/A

#### I/O Port of EUT:

I/O Port Type	Q'TY	Tested with	
Power in port	1	1	

#### Difference between model numbers as below:

These products listed in the report are identical, except that their model numbers are different just for marketing purpose.



## **SUPPORT EQUIPMENT**

No.	Equipment	Model #	Serial #	Trade Name	Data Cable	Power Cord
1.	N/A	N/A	N/A	N/A	N/A	N/A

\*\*Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

**Grounding:** Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.





## **TEST FACILITY**

**Location:** No. 7, Xinshidai industrial, Guantian Village,

Shiyan Town, Baoan District Shenzhen, China.

**Description:** There is one 3/10m open area test sites and one line conducted labs for

final test.

The Open Area Test Sites and the Line Conducted labs are constructed and calibrated to meet the FCC requirements in documents ANSI C63.4 and

CISPR 22/EN 55015 requirements.

**Site Filing:** A site description is on file with the Federal Communications

Commission, 7435 Oakland Mills Road, Columbia, MD 21046.

Accredited by FCC.

**Site Accreditation:** The certificate registration number is 963441

Accredited by TUV.

**Instrument Tolerance:** All measuring equipment is in accord with ANSI C63.4 and CISPR 22

requirements that meet industry regulatory agency and accreditation

agency requirement.

**Ground Plane:** Two conductive reference ground planes were used during the Line Conducted Emission, one in vertical and the other in horizontal. The dimensions of these ground planes are as below. The vertical ground plane was placed distancing 40 cm to the rear of the wooden test table on where the EUT and the support equipment were placed during test. The horizontal ground plane projected 50 cm beyond the footprint of the EUT system and distanced 80 cm to the wooden test table. For Radiated Emission Test, one horizontal conductive ground plane extended at least 1m beyond the periphery of the EUT and the largest measuring antenna, and covered the entire area between the EUT and the antenna. It has no holes or gaps having longitudinal dimensions larger than one-tenth of a wavelength at the highest frequency of measurement up to 1GHz.





## TEST EQUIPMENT LIST

**Instrumentation:** The following list contains equipment used at SinTek Laboratory Co., Ltd. for testing. The equipment conforms to the CISPR 16-1 / ANSI C63.2 Specifications for Electromagnetic Interference and Field Strength Instrumentation from 9kHz to 1.0GHz or above.

**Equipment used during the tests:** 

**Open Area Test Site:** A

Open Area Test Site A							
EQUIPMENT TYPE	LAST CAL.	CAL. DUE					
EMI TEST RECEIVER	SCHAFFNER	SCR3501	464	10/12/2018	10/12/2019		
AMPLIFIER	Com-Power	PA-103	161062	10/12/2018	10/12/2019		
ANTENNA	SCHAFFNER	CBL6111C	2775	10/12/2018	10/12/2019		
CABLE	TIME MICROWAVE	LMR-400	N-TYPE04	10/12/2018	10/12/2019		

**Conducted Emission Test Site:** 843

Conducted Emission Test Site 843								
EQUIPMENT     MFR     MODEL     SERIAL     LAST     CAL.       TYPE     NUMBER     NUMBER     CAL.     DUE								
Spectrum Analyzer	ADVANTEST	R3132	140301570	10/12/2018	10/12/2019			
LISN(EUT)	Com-Power	LI115	2027	10/12/2018	10/12/2019			

The calibrations of the measuring instruments, including any accessories that may effect such calibration, are checked frequently to assure their accuracy. Adjustments are made and correction factors applied in accordance with instructions contained in the manual for the measuring instrument.





## TEST EQUIPMENT LIST

ESD test (61000-4-2)							
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.		
ESD Generator	SCHAFFNER	NSG 435	5488	10/12/2018	10/12/2019		

Radiated	Electromagnetic 1	Field immunity	Measurement	t (61000-4-3)	
EQUIPMENT MFR		MODEL NUMBER	SERIAL NUMBER	LAST	CAL DUE.
TYPE		NUMBER	NUMBER	CAL.	
Signal Generator	Maconi	2022D	119246/003	10/12/2018	10/12/2019
Power Amplifier	M2S	A00181/1000	9801-112	10/12/2018	10/12/2019
Power Amplifier	M2S	AC8113/ 800-250A	9801-179	10/12/2018	10/12/2019
Power Antenna	SCHAFFNER	CBL6140A	1204	10/12/2018	10/12/2019

Fast Transients/Burst test (61000-4-4)/Surge(61000-4-5)/Voltage Dips							
	&Interruptions(61000-4-11)						
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.		
Fast Transients/Burst Generator	SCHAFFNER	MODULA 6000	34354	10/12/2018	10/12/2019		
7							

CS test (61000-4-6)							
EQUIPMENT TYPEMFR MFR NUMBERMODEL NUMBERSERIAL NUMBERLAST CAL.							
Signal Generator	SCHAFFNER	NSG 2070	1086	10/12/2018	10/12/2019		
CDN	SCHAFFNER	M016	20812	10/12/2018	10/12/2018		

Magnetic Field test (61000-4-8)						
EQUIPMENT TYPE	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.		
Magnetic Field Tester	SCHAFFNER	MAG100	2500	10/12/2018	10/12/2019	





# SECTION 1 EN 55015(LINE CONDUCTED AND RADIATED EMISSION)

## MEASUREMENT PROCEDURE (PRELIMINARY LINE CONDUCTED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN55015 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN55015.
- 1) All I/O cables were positioned to simulate typical actual usage as per EN55015.
- 2) The EUT received AC 230V/50Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane
- 3) All support equipment received AC 230V/50Hz power from a second LISN which supplied power source, if any.
- 4) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 5) Analyzer / Receiver scanned from 9kHz to 30MHz for emissions in each of the test modes.
- 6) During the above scans, the emissions were maximized by cable manipulation.
- 7) The following test mode(s) were scanned during the preliminary test:

Prel	iminary	Conducted Emission Test	;			
Frequency Range I	nvestigated	9KHz TO 30 MHz				
Mode of operation	Date	Data Report No.	Worst Mode			
ON	2019-01-08	VT-500D (L,N)				

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.

TEST REPORT



# MEASUREMENT PROCEDURE (FINAL LINE CONDUCTED EMISSION TEST)

- 1) EUT and support equipment was set up on the test bench as per step 9 of the preliminary test.
- 2) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using an Average detector.
- 3) The test data of the worst case condition(s) was reported on the Summary Data page.

#### **Data Sample:**

Freq.	Peak	Q.P.	Average	Q.P.	Average	Q.P.	Average	Note
MHz	Raw	Raw	Raw	Limit	Limit	Margin	Margin	
	dBuV	dBuV	dBuV	dBuV	dBuV	dB	dB	
X.XXX	41.90			56.00	46.00		-4.10	L 1

Freq.

Raw dBuV

Limit dBuV

Margin dB

Note

"\_\_\_"

- = Emission frequency in MHz
- = Uncorrected Analyzer/Receiver reading
- = Limit stated in standard
- = Reading in reference to limit
- = Current carrying line of reading
- = The emission level complied with the Average limits, with at least 2 dB margin, so no further recheck.





## LINE CONDUCTED EMISSION LIMIT

Frequency	Maximum RF Line Voltage			
	Q.P.	AVERAGE		
9kHz-50kHz	110dBuV			
50kHz-150kHz	90-80dBuV			
150kHz-0.5MHz	66-56dBuV	56-46dBuV		
0.5MHz-5MHz	56dBuV	46dBuV		
5.0MHz-30MHz	60dBuV	50dBuV		

**<sup>\*\*</sup>Note:** The lower limit shall apply at the transition frequency.





## MEASUREMENT PROCEDURE (PRELIMINARY RADIATED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55015 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55015.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55015.
- 4) The EUT received AC 230V/50Hz power from the outlet socket under the turntable. All support equipment received AC 230V/50Hz power from socket under the turntable, if any.
- 5) The antenna was placed at 10 meters away from the EUT as stated in EN 55015. The antenna connected to the Analyzer via a cable and at times a pre-amplifier would be used.
- 6) The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 7) The following test mode(s) were scanned during the preliminary test:

P			
Frequency Range	Investigated	30 MHz TO 1000 MHz	
Mode of operation	Date	Data Report No.	Worst Mode
ON	2019-01-08	VT-500D (V, H)	$\boxtimes$

Then, the EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for final testing.



## MEASUREMENT PROCEDURE (FINAL RADIATED EMISSION TEST)

- 1) EUT and support equipment were set up on the turntable as per step 7 of the preliminary test.
- 2) The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 3) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and Q.P./Peak reading is presented.
- 4) The test data of the worst case condition(s) was reported on the Summary Data page.

**Data Sample:** 

Freq. (MHz)	Ant. H/V	Reading(RA) (dBuV)	Corr.Factor(CF) (dB)	Measured(FS) (dBuV/m)	Limits(QP) (dBuV/m)	Safe Margins (dBuV/m)	Note
34.85	V	9.21	16.47	25.68	30.00	-4.32	P

Freq.
Reading (dBuV/m)
Corr. Factor (dB)
Measured dBuV/m
Limit dBuV/m
Margin dB
P

Q

= Emission frequency in MHz

= Uncorrected Analyzer / Receiver reading

= Correction factors of antenna factor and cable loss

= Raw reading converted to dBuV/m and CF added

= Limit stated in standard

= Reading in reference to limit

=Peak Reading

=Quasi-peak





## **RADIATED EMISSION LIMIT**

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBu V/m/ Q.P.)	
30-230	3	40	
230-1000	3	47	

**<sup>\*\*</sup>Note:** The lower limit shall apply at the transition frequency.





## **BLOCK DIAGRAM OF TEST SETUP**

**System Diagram of Connections between EUT and Simulators** 

**EUT:**LED SPORTS LIGHT

Trade Name : V-TAC

**Model Number :** VT-500D

AC Mains EUT

(EUT: LED SPORTS LIGHT)





## **SUMMARY DATA** (LINE CONDUCTED TEST)

**Model Number:** VT-500D **Location:** 843-site

**Tested by:** steven

Test Mode: ON

Test Results: Passed

**Temperature:** 21°C **Humidity:** 60%RH

(The chart below shows the highest readings taken from the final data)

FREQ	PEAK	Q.P.	AVG	Q.P.	AVG	Q.P.	AVG	NOTE
KHz	RAW	RAW	RAW	Limit	Limit	Margin	Margin	
	dBuV	dBuV	dBuV	dBuV	dBuV	dB	dB	
60.8880	55.99			88.91	88.91	-32.92	N/A	L1
154.5530	60.71		37.54	65.87	55.87	-5.16	-18.33	L1
1972.2350	46.74		35.26	56.00	46.00	-9.26	-10.74	L1
4743.6860	54.03	51.32	40.12	56.00	46.00	-4.68	-5.88	L1
7919.2400	56.37		40.08	60.00	50.00	-3.63	-9.92-	L1
24991.6870	56.34		45.38	60.00	50.00	-3.66	-4.62	L1
60.7470	55.95			88.93	88.93	-32.98	N/A	L2
158.2550	57.67		36.54	65.76	55.76	-8.09	-19.22	L2
2207.0520	48.21		33.58	56.00	46.00	-7.79	-12.42	L2
4619.6550	52.47		38.48	56.00	46.00	-3.53	-7.52	L2
7615.2020	54.45		39.17	60.00	50.00	-5.55	-10.83	L2
24351.6470	56.46		46.58	60.00	50.00	-3.42	-3.42	L2

L1 = Line One (Hot side) / L2 = Line Two (Neutral side)
\*\*NOTE: "---" denotes the emission level was or more than 2dB below the Average limit, so no re-check anymore.



## **SUMMARY DATA**

(RADIATED EMISSION TEST)

**Model Number:** VT-500D **Location:** A-site

**Tested by:** salon **Test Distance:** 3m

**Test Mode:** ON **Test Results:** Passed

**Detector Function:** Peak/QP

**Temperature:** 21°C **Humidity:** 60%RH

(The chart below shows the highest readings taken from the final data)

Freq.	Ant.	Reading(RA)	Corr.Factor(CF)	Measured(FS)	Limits(QP)	Safe Margins	Note
(MHz)	H/V	(dBuV)	(dB)	(dBuV/m)	(dBuV/m)	(dBuV/m)	Note
30.00	V	11.11	8.40	19.51	40.00	-20.49	P
42.13	V	12.99	10.02	23.01	40.00	-16.99	P
46.98	V	13.35	10.33	23.68	40.00	-16.32	P
80.93	V	12.76	15.61	28.37	40.00	-11.63	P
90.63	V	19.22	18.87	38.09	43.50	-5.41	P
207.03	V	18.32	16.56	34.88	43.50	-8.62	P
30.00	Н	3.05	8.00	11.05	40.00	-28.95	P
42.13	Н	8.70	10.44	19.14	40.00	-20.86	P
95.48	Н	16.64	5.66	22.30	43.50	-21.20	P
122.15	Н	21.32	10.37	31.69	43.50	-11.81	P
194.90	Н	22.35	12.29	34.64	43.50	-8.86	P
253.10	Н	21.64	17.62	39.26	46.00	-6.74	P





# SECTION 2 EN 61000-3-2 & EN 61000-3-3(POWER HARMONICS & VOLTAGE FLUCTUATION / FLICKER)

#### POWER HARMONICS MEASUREMENT

**Port** : AC mains

**Basic Standard** : EN 61000-3-2 (2006+A1:2009+A2:2009)

Limits :  $V \mid \text{CLASS C}$ ;  $\mid \text{CLASS D}$ 

**Tester** : Ray **Temperature** : 24°C **Humidity** : 60%

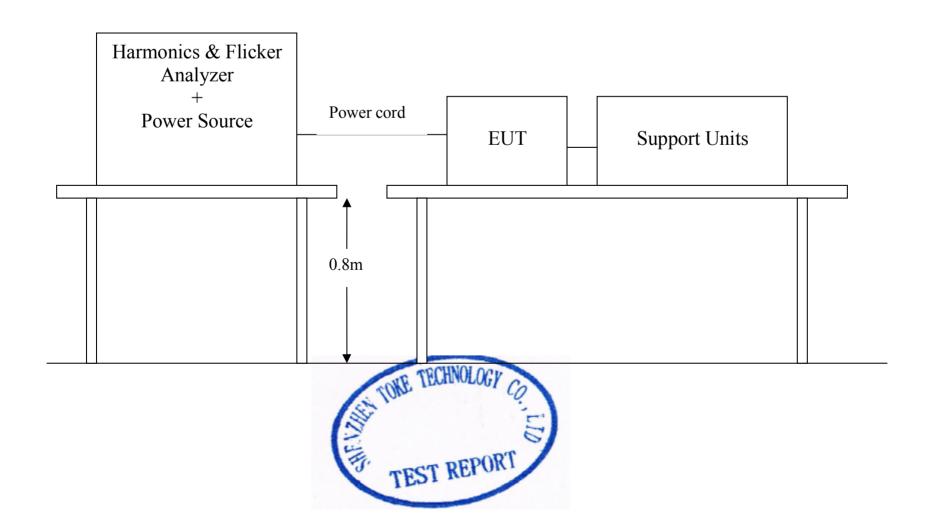
#### **VOLTAGE FLUCTUATION/FLICKER MEASUREMENT**

**Port** : AC mains

**Basic Standard** : EN 61000-3-3 (2008) **Limits** : section 5 of EN 61000-3-3

**Tester** : Ray **Temperature** : 24°C **Humidity** : 60%

## **Block Diagram of Test Setup:**



### **Result: PASS**

Please see the attached test data

**N/A**(The EUT max power be not more than 25W, this test items not be required.)

## **SECTION 3** EN 61000-4-2 (ELECTROSTATIC DISCHARGE)

## **ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST**

**Port** : Enclosure

**Basic Standard**: EN 61000-4-2

**Test Level:**  $\pm 8 \text{ kV (Air Discharge)}$ 

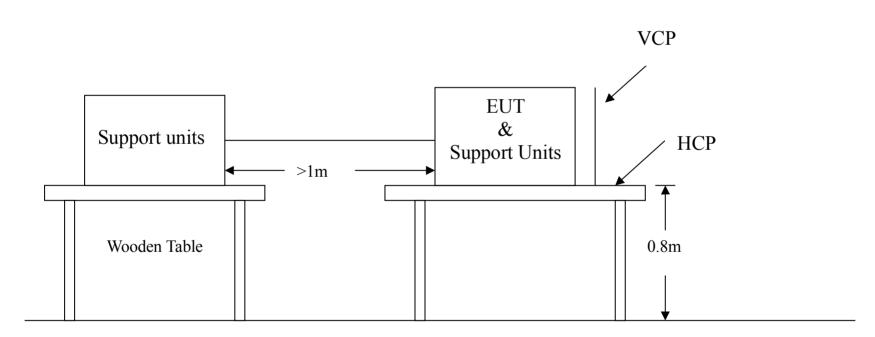
±4kV (Contact Discharge)

**Performance Criteria**: B (Standard require)

**Tester:** Steven **Temperature/Humidity:** 25°C/60%

### **Block Diagram of Test Setup:**

(The 470 k ohm resistors are installed per standard requirement)



Ground Reference Plane





### **Test Procedure:**

- 2. The EUT was located 0.1 m minimum from all side of the HCP. The support units were located 1 m minimum away from the EUT.
- 3. Set up EUT with the auxiliary equipment.
- 4. Let EUT work in the test mode and measure it.
- 5. Active the communication function if the EUT with such port(s).
- 6. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
- 7. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
- 8. The application of ESD to the contact of open connectors is not required.
- 9. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

**Note:** As per the A2 to EN 61000-4-2, a bleed resistor cable is connected between the EUT and HCP during the test.

The electrostatic discharges were applied as follows:

Amount of	Voltage	Coupling	Result (Pass/Fail)
Discharges			
Mini 10 /Point	$\pm8\mathrm{kV}$	Air Discharge	Pass
Mini 10 /Point	$\pm 4 \mathrm{kV}$	Contact Discharge	Pass
Mini 10 /Point	$\pm 4 \mathrm{kV}$	Indirect Discharge HCP	Pass
Mini 10 /Point	$\pm 4 \mathrm{kV}$	Indirect Discharge VCP(Front)	Pass
Mini 10 /Point	$\pm 4 \mathrm{kV}$	Indirect Discharge VCP(Left)	Pass
Mini 10 /Point	$\pm 4 \mathrm{kV}$	Indirect Discharge VCP(Back)	Pass
Mini 10 /Point	$\pm 4 \mathrm{kV}$	Indirect Discharge VCP(Right)	Pass







<u>Pe</u>	erformance &	& Result:
Ŋ	<b>∕</b> Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
		V PASS FAILED





#### EN 61000-4-3 (RADIATED ELECTROMAGNETIC FIELD) **SECTION 4**

#### RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

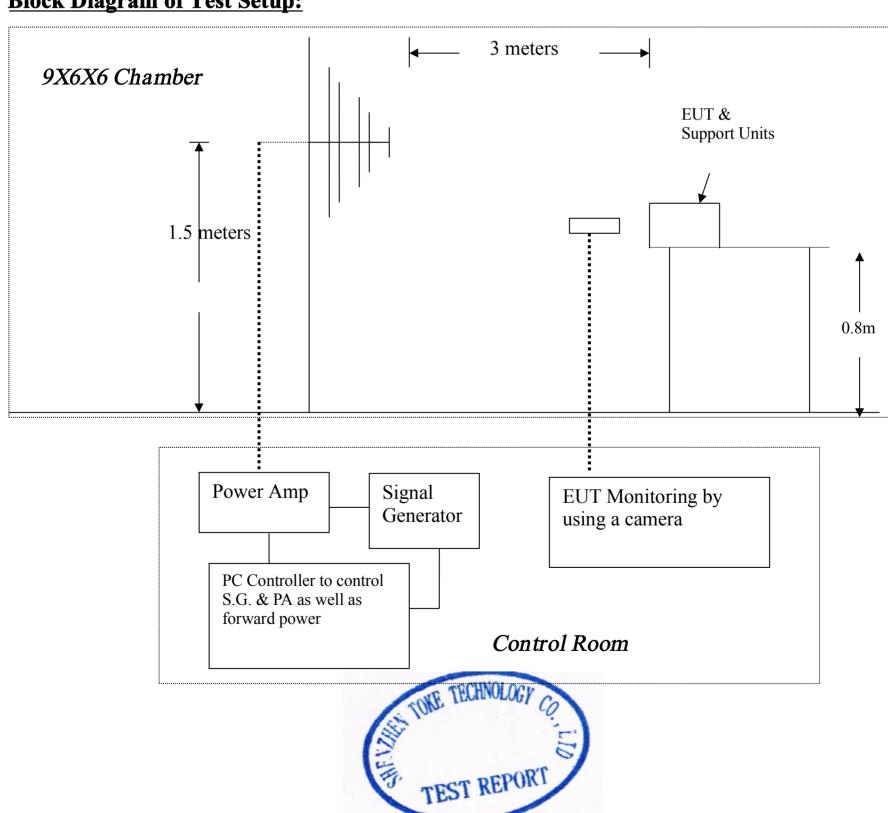
: Enclosure **Port** : EN61000-4-3 **Basic Standard** 

Requirements : 3 V/m(non-modulation) with 80% AM. 1kHz

**Performance Criteria**: A (Standard require)

: Steven **Tester** : 25°C **Temperature** Humidity : 60%

### **Block Diagram of Test Setup:**





#### **Test Procedure:**

- 5) The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per EN 61000-4-3.
- 6) Set up EUT with the auxiliary equipment.
- 7) Let EIT work in the test mode and measure it.
- 8) Setting the testing parameters of RS test software per EN 61000-4-3.
- 9) Performing the pre-test at each side of with double specified level (6V/m) at 4% steps.
- 10) From the result of pre-test in step 5, choice the worst side of EUT for final test from 80 MHz to 1000 MHz at 1% steps.
- 11) Recording the test result in following table.
- 12) It is not necessary to perform test as per annex A of EN 55024 if the EUT doesn't belong to TTE product.

#### **EN 61000-4-3 Preliminary test conditions:**

Test level : 6V/m

Steps : 4 % of fundamental

Dwell Time : 1 sec

Range (MHz)	Field	Non-modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	6V/m	Yes	Н	Front	Pass
80-1000	6V/m	Yes	V	Front	Pass
80-1000	6V/m	Yes	Н	Right	Pass
80-1000	6V/m	Yes	V	Right	Pass
80-1000	6V/m	Yes	Н	Back	Pass
80-1000	6V/m	Yes	V	Back	Pass
80-1000	6V/m	Yes	Н	Left	Pass
80-1000	6V/m	Yes	V	Left	Pass

#### EN 61000-4-3 Final test conditions:

Test level : 3V/m

Steps : 1 % of fundamental

Dwell Time : 1 sec

Range (MHz)	Field	Non-modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	3V/m	Yes	Н	Back	Pass
80-1000	3V/m	Yes	V	Back	Pass





## **Performance & Result:**

V	<b>∐ Criteria A:</b>	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criteria C:	Temporary loss of function is allowed, provided the functions self-recoverable or can be restored by the operation of controls.
		V PASS FAILED



## SECTION 5 EN 61000-4-4 (FAST TRANSIENTS/BURST)

#### **FAST TRANSIENTS/BURST IMMUNITY TEST**

**Port** : On Power Supply Lines

**Basic Standard**: EN 61000-4-4

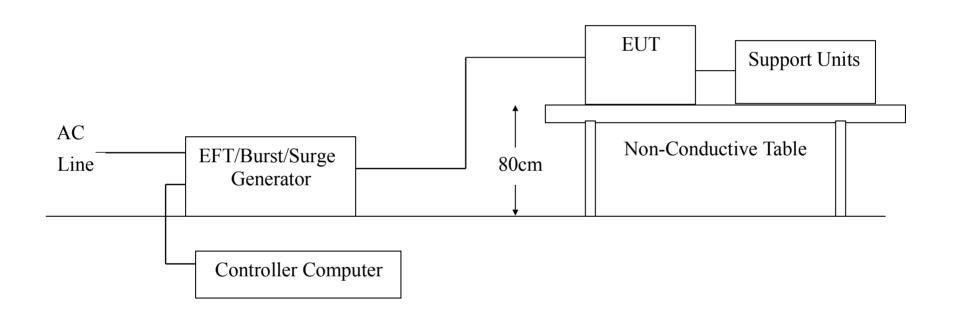
**Requirements** : +/- 1kV Direct for Power Supply Lines;

+/- 2kV Clamp for Power Supply Lines

**Performance Criteria**: B (Standard require)

**Tester** : Steven **Temperature** : 25°C **Humidity** : 60%

## **Block Diagram of Test Setup:**







## **Test Procedure:**

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
- 2. A 1.0 meter long power cord was attached to EUT during the test.
- 3. The length of communication cable between communication port and clamp was keeping within 1 meter.
- 4. Set up EUT with the auxiliary equipment.
- 5. Let EUT work in the test mode and measure it.
- 6. Related peripherals work during the test.
- 7. Recording the test result as shown in following table.

#### **Test conditions:**

Impulse Frequency: 5kHz

Tr/Th: 5/50ns

Burst Duration: 15ms Burst Period: 300ms

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	+/- 1	Direct	Pass
N	+/- 1	Direct	Pass
L+N	+/- 1	Direct	Pass

## **Performance & Result:**

loss of function is allowed below a performance level specification when the apparatus is used as intended. In some cases the property of the control of the	ed by the manufacturer,
replaced by a permissible loss of performance.	performance level may be
Criteria B: The apparatus continues to operate as intended after the test. performance or loss of function is allowed below a performan manufacturer, when the apparatus is used as intended. In so level may be replaced by a permissible loss of performance. degradation of performance is however allowed.	nce level specified by the ome cases the performance
Criteria C: Temporary loss of function is allowed, provided the function be restored by the operation of controls.	ns self recoverable or can
V PASS TOTE TECHNICOT EAILED	

## SECTION 6 EN 61000-4-5 (SURGE IMMUNITY)

## **SURGE IMMUNITY TEST**

**Port** : On Power Supply Lines

**Basic Standard**: EN 61000-4-5

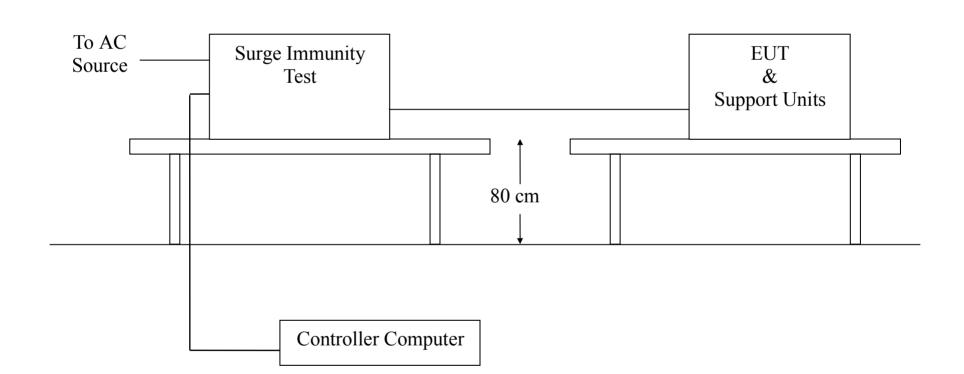
**Requirements** : +/- 0.5kV (Line to Line)

: +/- 1kV (Line to Ground)

**Performance Criteria :** C ( Standard require )

Tester : Steven
Temperature : 25°C
Humidity : 60%

## **Block Diagram of Test Setup:**







## **Test Procedure:**

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
- 2. Set up EUT with the auxiliary equipment.
- 3. Let EUT work in the test mode and measure it.
- 4. Related peripherals work during the test.
- 5. Recording the test result as shown in following table.

## **Test conditions:**

Voltage Waveform : 1.2/50 us Current Waveform : 8/20 us

Polarity : Positive/Negative

Phase angle : 90°,270°

Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	0.5	Positive	Capacitive	Pass
L1-L2	0.5	Negative	Capacitive	Pass

## **Performance & Result:**

$\overline{V}$	Criteria A:	The apparatus continues to operate as intended. No degradation of performance or
	-	loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.   V PASS TEST REPORT FAILED



# SECTION 7 EN 61000-4-6(CONDUCTED DISTURBANCE/INDUCED BY RADIO-FREQUENCY FIELD)

**Port** : On Power Supply Lines

**Basic Standard**: EN 61000-4-6

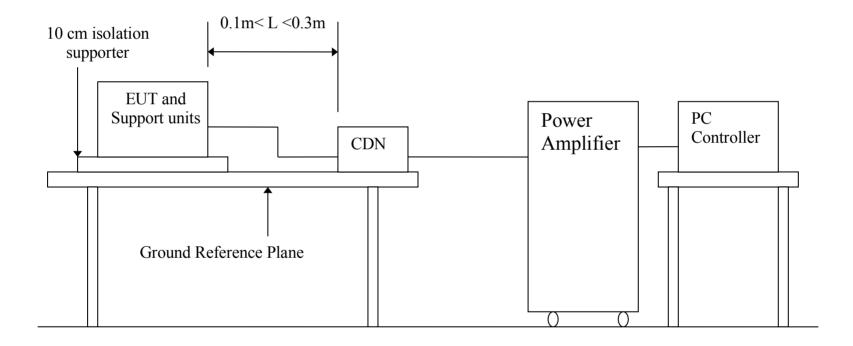
**Requirements** : 3V(non-modulation) with 80% AM. 1kHz

**Injection Method** : CDN

**Performance Criteria**: A (Standard require)

**Tester** : Steven **Temperature** : 25°C **Humidity** : 60%

## **Block Diagram of Test Setup:**







## **Test Procedure:**

- 1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- 2. Set up EUT with the auxiliary equipment.
- 3. Let EUT work in the test mode and measure it.
- 4. Related peripherals work during the test.
- 5. Setting the testing parameters of CS test software per EN 61000-4-6.
- 6. Recording the test result in following table.

#### **Test conditions:**

Frequency Range : 0.15MHz-80MHz Frequency Step : 1% of fundamental

Dwell Time : 1 sec

Range (MHz)	Field	Non-modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

## **Performance & Result:**

V Criteria A:	The apparatus continues to operate as intended. No degradation of performance or
	loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self-recoverable or can
	be restored by the operation of controls.
	V PASS FAILED



# SECTION 8 EN 61000-4-11 (VOLTAGE DIPS, SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS)

#### **VOLTAGE DIPS / SHORT INTERRUPTIONS**

**Port** : On Power Supply Lines

**Basic Standard** : EN 61000-4-11

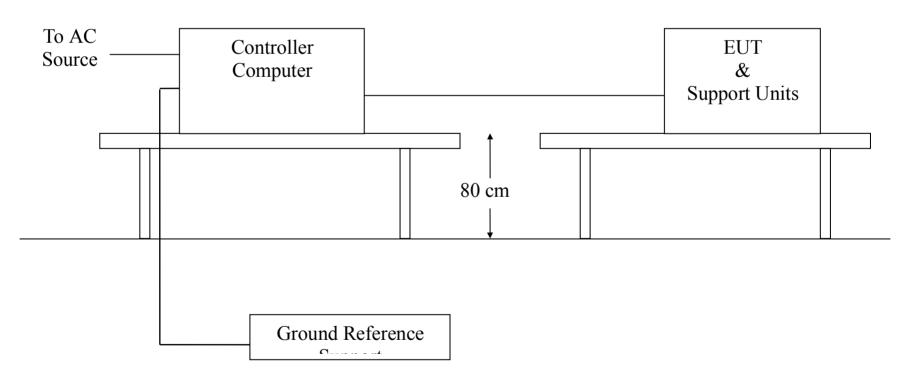
**Requirement** : PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

Voltage	Test Level % U <sub>T</sub>	Reduction (%)	Duration ( periods )	Performance Criteria
Dips	70	30	10	С

Voltage	Test Level % U <sub>T</sub>	Reduction (%)	Duration (periods)	Performance Criteria
Interceptions	0	100	0.5	В

Test Interval : Min. 10 sec.
Tester : Steven
Temperature : 25°C
Humidity : 60%

## **Block Diagram of Test Setup:**







## **Test Procedure:**

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. Set up EUT with the auxiliary equipment.
- 3. Let EUT work in the test mode and measure it.
- 4. Setting the parameter of tests and then Perform the test software of test simulator.
- 5. Conditions changes to occur at 0 degree crossover point of the voltage waveform.
- 6. Recording the test result in test record form.

## **Test conditions:**

The duration with a sequence of three dips/interruptions with interval of 10 s minimum (Between each test event)

#### **Voltage Dips:**

Test Level	Reduction	Duration Observation		Meet Performance
$\%  \mathrm{U_T}$	(%)	( periods)		Criteria
70	30	10	Normal	В

**Voltage Interruptions:** 

Test Level % U <sub>T</sub>	Reduction (%)	Duration ( periods)	Observation	Meet Performance Criteria
0	100	0.5	EUT shut down,and self-recovered	В



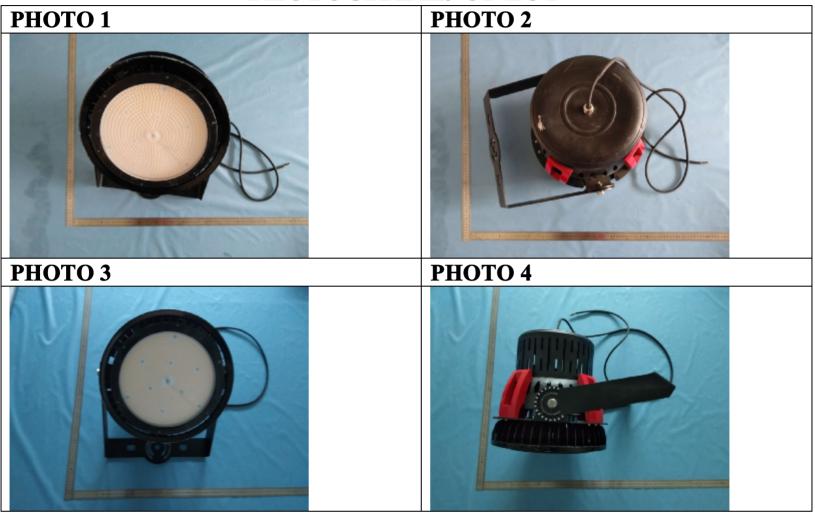


Performance & Result:	
Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
V Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self-recoverable or can be restored by the operation of controls.
	V PASS FAILED





## APPENDIX 1 PHOTOGRAPHS OF EUT







## **Conditions of Issuance of Test Reports**

- 1. All samples and goods are accepted by the SHENZHEN TOKE LABORATORY CO.,LTD. (the "Company") solely for testing and reporting in accordance with the following terms and conditions. The company provides its services on the basis that such terms and conditions constitute express agreement between the Company and any person, firm or company requesting its services (the "Clients").
- 2. Any report issued by Company as a result of this application for testing services (the "Report") shall be issued in confidence to the Clients and the Report will be strictly treated as such by the Company. It may not be reproduced either in its entirety or in part and it may not be used for advertising or other unauthorized purposes without the written consent of the Company. The Clients to whom the Report is issued may, however, show or send it, or a certified copy thereof prepared by the Company to its customer, supplier or other persons directly concerned. The Company will not, without the consent of the Clients, enter into any discussion or correspondence with any third party concerning the contents of the Report, unless required by the relevant governmental authorities, laws or court orders.
- 3. The Company shall not be called or be liable to be called to give evidence or testimony on the Report in a court of law without its prior written consent, unless required by the relevant governmental authorities, laws or court orders.
- 4. The Report refers only to the sample tested and does not apply to the bulk, unless the sampling has been carried out by the Company and is stated as such in the Report.
- 5. In the event of the improper use of the report as determined by the Company, the Company reserves the right to withdraw it, and to adopt any other additional remedies which may be appropriate.
- 6. Samples submitted for testing are accepted on the understanding that the Report issued cannot form the basis of, or be the instrument for, any legal action against the Company.
- 7. The Company will not be liable for or accept responsibility for any loss or damage however arising from the use of information contained in any of its Reports or in any communication whatsoever about its said tests or investigations.
- 8. Clients wishing to use the Report in court proceedings or arbitration shall inform the Company to that effect prior to submitting the sample for testing.
- 9. Subject to the variable length of retention time for test data and report stored hereinto as otherwise specifically required by individual accreditation authorities, the Company will only keep the supporting test data and information of the test report fora period of ten years. The data and information will be disposed of after the aforementioned retention period has elapsed. Under no circumstances shall we provide any data and information which has been disposed of after retention period. Under no circumstances shall we be liable for damage of any kind, including (but not limited to) compensatory damages, lost profits, lost data, or any form of special, including (but not limited to) required damages of any kind, whether based on breach of contract of warranty, tort (including negligence), product liability or otherwise, even if we are informed in advance of the possibility of such damages.